

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/656,584	HSU ET AL.	
Examiner	Art Unit	
Binh X. Tran	1765	

SEARCHED					
Class	Subclass	Date	Examiner		
438	705	8/2/2005	ВТ		
438	708	8/2/2005	вт		
438	715	8/2/2005	ВТ		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
438	705	8/2/2005	ВТ		
438	708	8/2/2005	вт		
438	715	8/2/2005	вт		
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	SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
777	DATE	EXMR			
Update text search using USPG-PUB, USPAT, EPO, JPO, DERWENT databases	8/2/2005	ВТ			
438/710; 438/725 text search only. See search history	8/2/2005	ВТ			